


<b>Search Notes</b> 	<b>Application/Control No.</b> 10774577	<b>Applicant(s)/Patent Under Reexamination</b> COGGAN ET AL.
	<b>Examiner</b> Dawn Garrett	<b>Art Unit</b> 1786

### SEARCHED

Class	Subclass	Date	Examiner
428	690, 917 (limited by text searching for all listed, see EAST search printout)	6-5-08	DG
313	504, 506	6-5-08	DG
	see EAST search history printout(s) in application file	through 10/2011	DG

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor name search updated	6-5-08	DG
STIC structure search by EIC 1700 (see printout attached)	5-2008	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	6-5-08	DG
See all prior search notes pages in application file		
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-3-08	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	6-1-2009, 6-4-2009	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-2-2009	DG
Reviewed STIC structure searches in application file	12-2-2009	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	7-1-2010	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-16-2010	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	4-27-2011	DG
STN search - see printout	4-27-2011	DG
Updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	10-8-2011 AND 10-9-2011	DG

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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